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Barbara Haggerty

Name

Barbara Haggerty  
Signature

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Patent Application Of: Roman Frick et al.

Filed: June 25, 2003

For: Stand For A Surgical Microscope

the specification of which is being transmitted herewith.

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

**INFORMATION DISCLOSURE STATEMENT**

**Pursuant to 37 CFR 1.56**

Applicant wishes to make of record the following references under the provisions of 37 C.F.R. §1.97 (legible copies are provided).

References cited

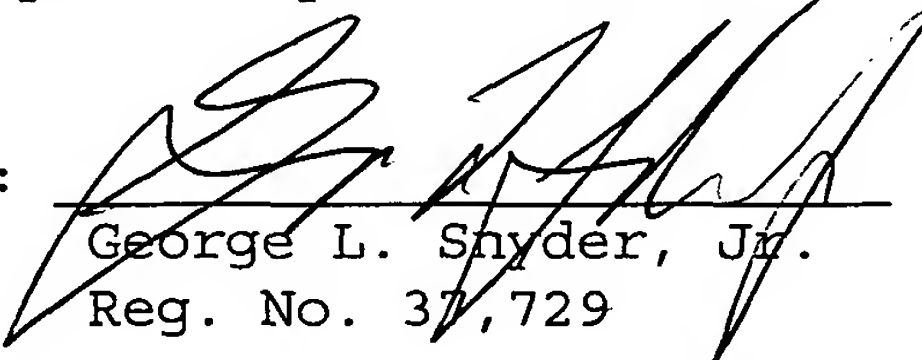
- 1) German Patent No. De 101 23 166 A1

IDS For: Stand For A Surgical Microscope  
Inventor: Roman Frick et al.

Please see attached Form 1449 for list of publications.  
Legible copies of all publications listed are enclosed.

The person making this statement is the patent attorney who  
signs below on the basis of the information supplied by the  
inventors, and as the attorney associated with the filing and  
prosecution of this application (37 CFR 1.56(a)).

Respectfully Submitted,

By:   
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June 25, 2003

# **INFORMATION DISCLOSURE STATEMENT BY APPLICANT**

(Use as many sheets as necessary)

<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b> (Use as many sheets as necessary)				Application Number		
				Filing Date		06/25/03
				First Named Inventor		Roman Frick et al.
				Art Unit		
				Examiner Name		
Sheet	3	of	3	Attorney Docket Number		33997.0085

## **U.S. PATENT DOCUMENTS**

Examiner Initials*	Cite No. <sup>1</sup>	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code <sup>2</sup> (if known)			
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## **FOREIGN PATENT DOCUMENTS**

Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T <sup>6</sup>
		Country Code <sup>3</sup> Number <sup>4</sup> Kind Code <sup>5</sup> (if known)				
	1	DE 102 23 166 A1	12-12-2002	Leica Microsystems AG		

Examiner Signature		Date Considered	
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<sup>1</sup> Applicant's unique citation designation number (optional). <sup>2</sup> See Kinds Codes of USPTO Patent Documents at [www.uspto.gov](http://www.uspto.gov) or MPEP 901.04. <sup>3</sup> Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup> For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup> Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. <sup>6</sup> Applicant is to place a check mark here if English language Translation is attached.